Introduction to Nanophysics

Prof. J. Raynien Kwo

Department of Physics National Tsing Hua University

## What is the size for a "nano" ?

One (nm) equals to 1/100000000 (10-9) meter

厘米 10<sup>-3</sup> m, Macro 微米 10<sup>-6</sup> m, Micro 奈米 10<sup>-9</sup> m, Meso

## R. Feymann Already Knew about this !

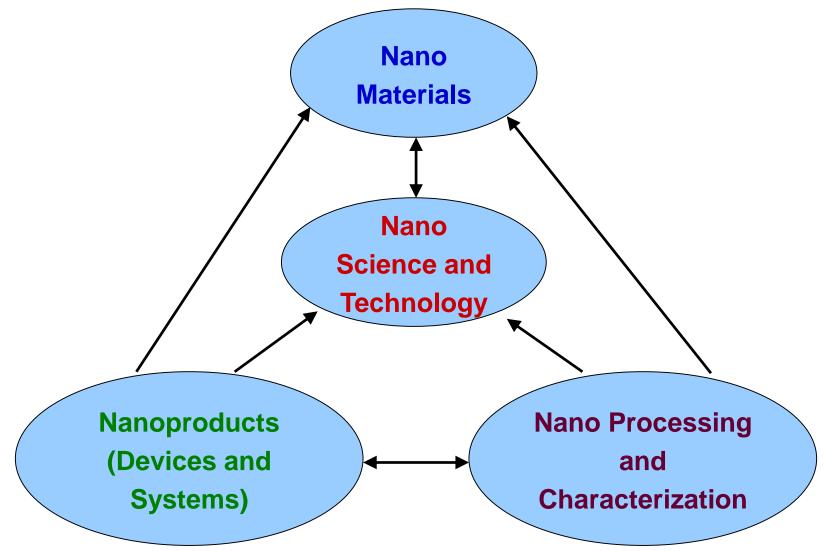


## " There's plenty of room at the bottom ! " in 1959.

### Physicists noticed the "Nano" as early as .....

- 4th Century, Roman glassmaker: the color of glasses can be changed by mixing in metal particles
- In 1883, Films containing silver halides for photography were invented by George Eastman, founder of Koda.
- 1908, Gustay Mie first provided the explanation of the size dependence of color.
- Vision from Feynman in 1959: "There is plenty room at the bottom", and also recognized "there are plenty of nature-given nanostructures in biological systems".
- 1950-1960, small metal particles were investigated by physicists.
- 1957, Ralph Landauer realized the importance of quantum mechanics plays in devices at small scales.
- Before 1997 => mesoscopic (or low dimensional) physics : quantum dots, wells, wires....are known already.

#### Major Topics of Nanoscience and Technology



## What is the Nano Technology?

Science and Technology Down scaling to size under 100 nm:

Via "Top-down" lithographic pattering: -- Moore's law !

Manipulate the atomic and molecular structures:

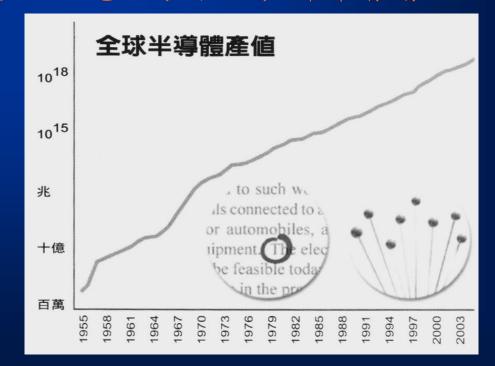
"Bottom-up" nano materials, growth and assembly.

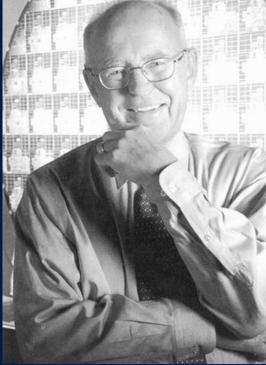
Feymann: There's plenty of room at the bottom



## 近來大力推動奈米科技的背景

# 來自微電子學可能遭遇瓶頸的考慮Moore's Law: 摩爾定律A 30% decrease in the size of<br/>printed dimensions every 1.5 years.<br/> <br/> <br/> <br/> <br/> <br/>



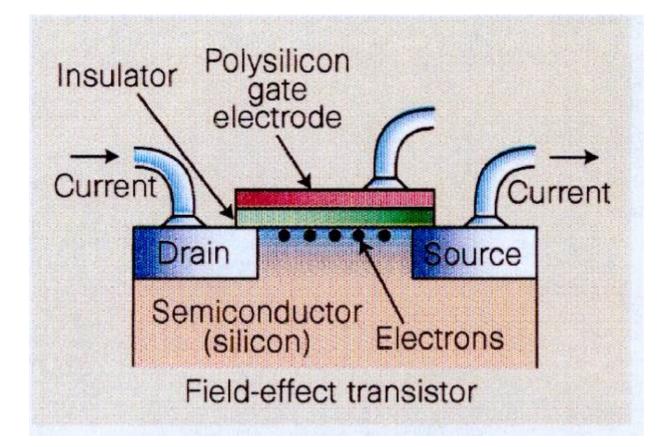


**Gordon Moore** 

## Two basic modern electronic technologies in condensed matter physics field

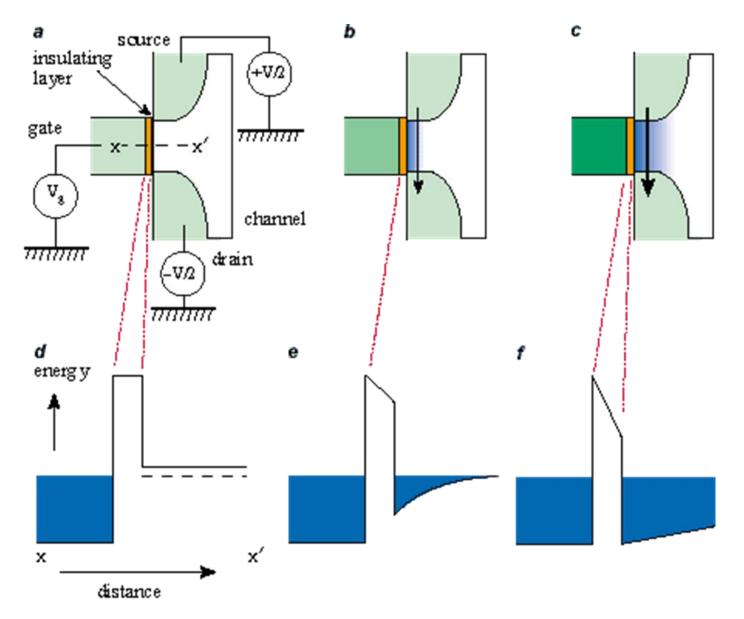
MOSFETMRAM

#### Metal-Oxide-Field Effect Transistor (MOSFET)

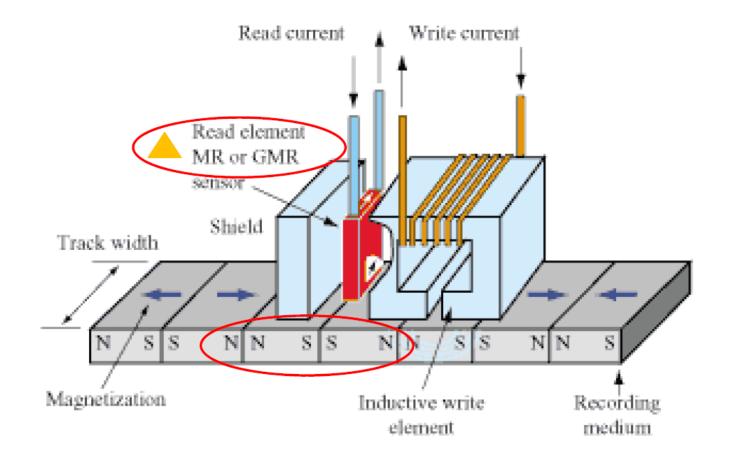


1960 Kahng and Atalla, First MOSFET 1970 First IC, 1 kbit, 750 khz microprocessor

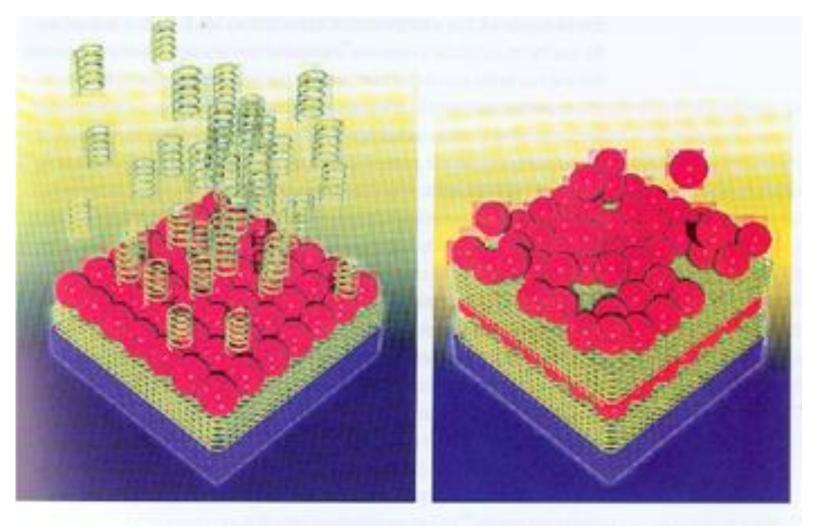
#### 電子科技之基礎--MOSFET (metal-oxide-semiconductor field-effect transistor)



電子科技之基礎--磁記錄



## **Bottom-up Nano systems & Self-Assembly** enabling to design large molecules and nano materials

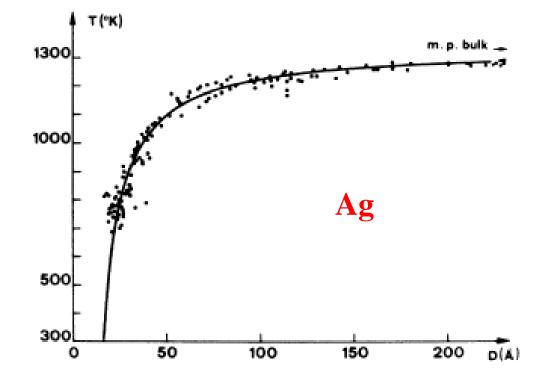


## Five major lessons that we learned

## **The First Lesson :**

## **Bulk-to-nano Transition**

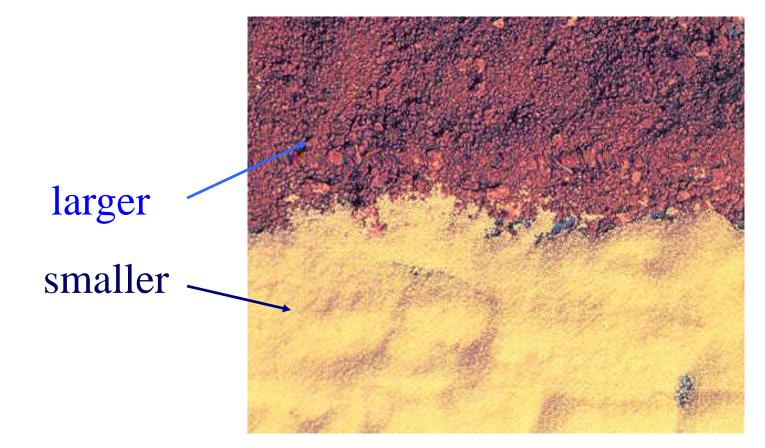
#### **Ex: size-dependence of melting temperature**



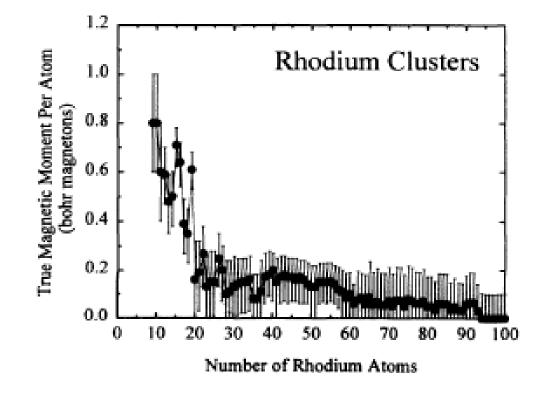
Ph. Buffat and J-P. Borel, Phys. Rev. A13, 2287 (1976)

#### **Ex: size-dependence of color**

#### powered cadmium selenide (CdSe)



#### **Ex: size-dependence of magnetism**



A. J. Cox et al. Phys. Rev. B49, 12295 (1994)

**The Second Lesson : The Advent of Nano Era** 

The ability of growing materials and structures on the nano scale

The ability of detecting and manipulating on the nano scale (I) Advance in thin film growth:

Molecular beam epitaxy (MBE), atomic layer deposition (ALD), laser MBE, etc...

For nano electronics in metals, oxides, and semiconductors.

## (II) Detection at nano scale: STM, AFM, MFM, STEM, Cs-TEM

➢ In 1982, Binning, and Rohrer in IBM invented scanning tunneling microscope (STM).

➢ In 1986, Binning, Quate, and Gerber invented atomic force microscope (AFM).

#### **Integrated Multi-chamber MBE System**



Now located at the Nano Science & Technology Center, ITRI, Hsin Chu, Taiwan

For producing metals, oxides and semiconductor films on the nano scale



#### Scanning Tunneling Microscope (STM)

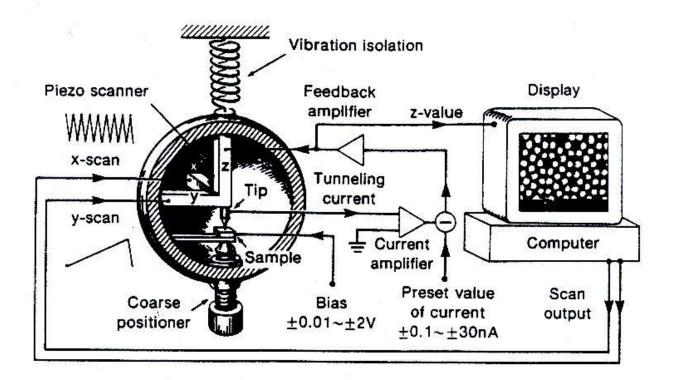
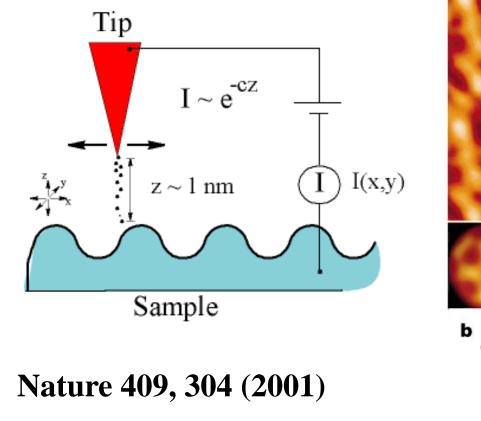
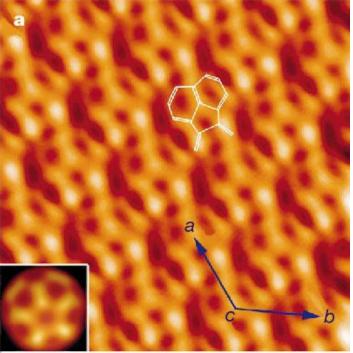


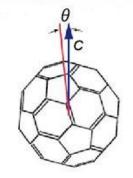
Figure 1.10 Scanning tunneling microscope. (From C. Julian Chen, Introduction to Scanning Tunneling Microscopy, Oxford: Oxford University Press, 1993.)

## Scanning Tunneling Microscope (STM) – Physicist used to detect nano structures



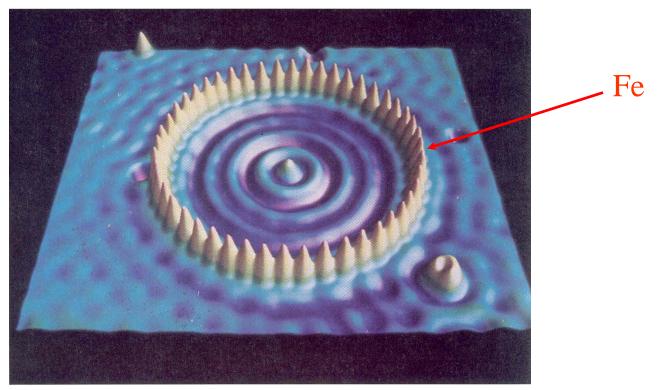






### **Quantum Corral**

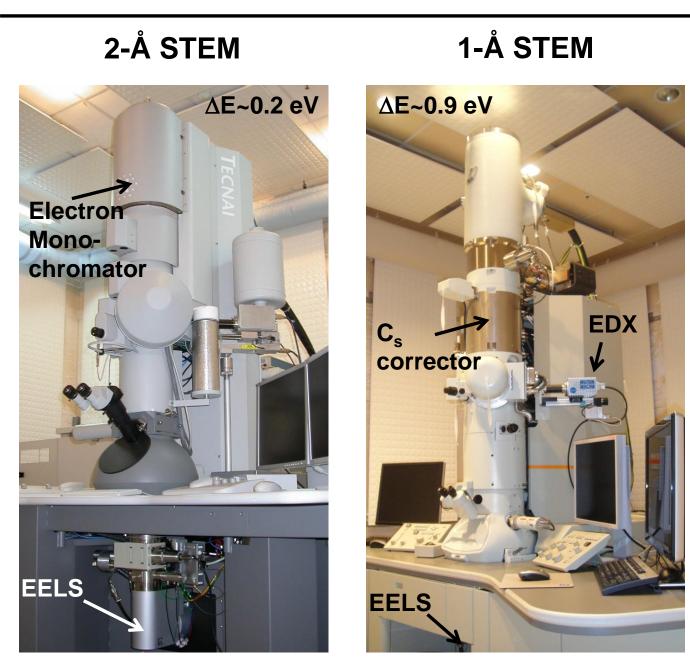
#### of 7.13 nm radius, 48 Fe atoms on the Cu (111) surface



This STM image shows the direct observation of standing-wave patterns in the local density of states of the Cu(111) surface. These spatial oscillations are quantum mechanical interference patterns caused by scattering of the 2D electron gas off the Fe adatoms and point defects.

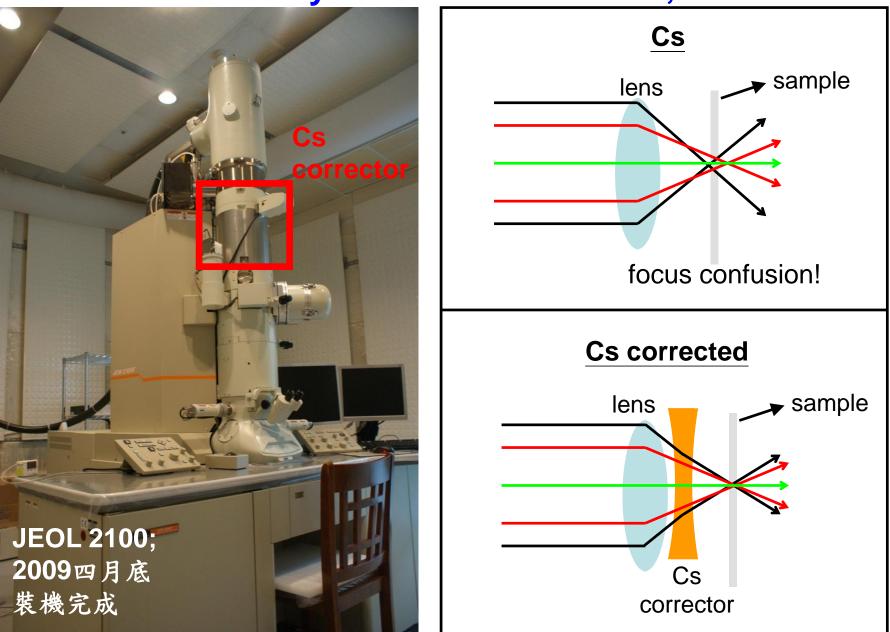
Crommue, Luts, and Eigler, Science 262, 218-220, 1993

#### **S**canning **T**ransmission **E**lectron **M**icroscopy



Prof. C. H. Chen and Dr. M.-W. Chu in CCMS/NTU.

#### Spherical Aberration Corrected (球面相差) Cs-STEM by C. H. Chen at CCMS, NTU



#### High-Angle ADF: Si dumbbell, 1.36 Å spacing

(440); 0.96Å

0

(004) 1.36Å

#### 15s exposure

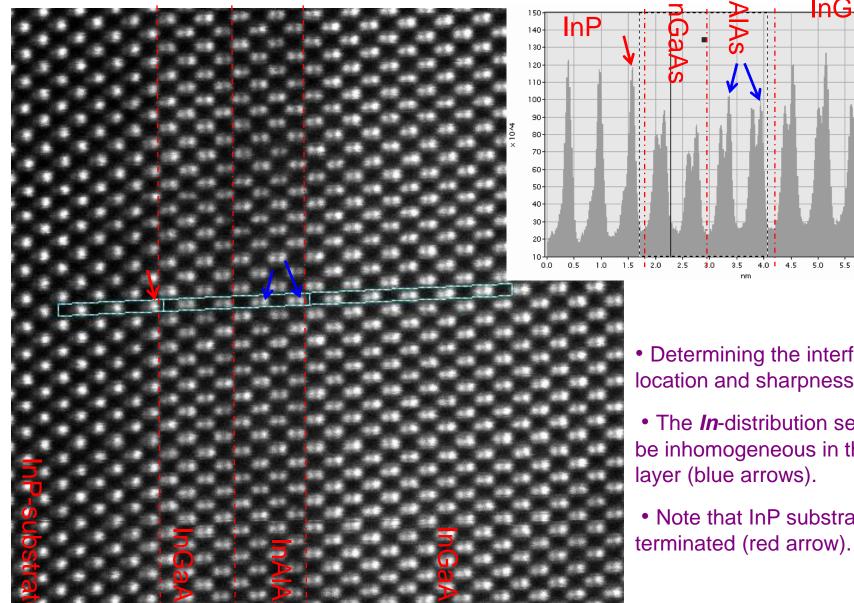
.

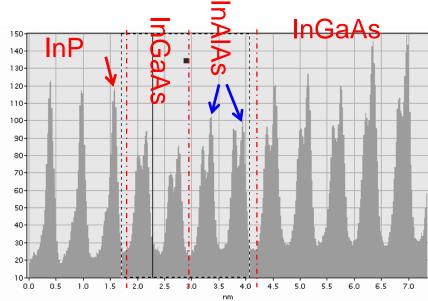
#### Si [110]

#### 60s exposure

Drift ~1Å/min !!

#### InGaAs/InAIAs superlattices on InP Substrate by MBE



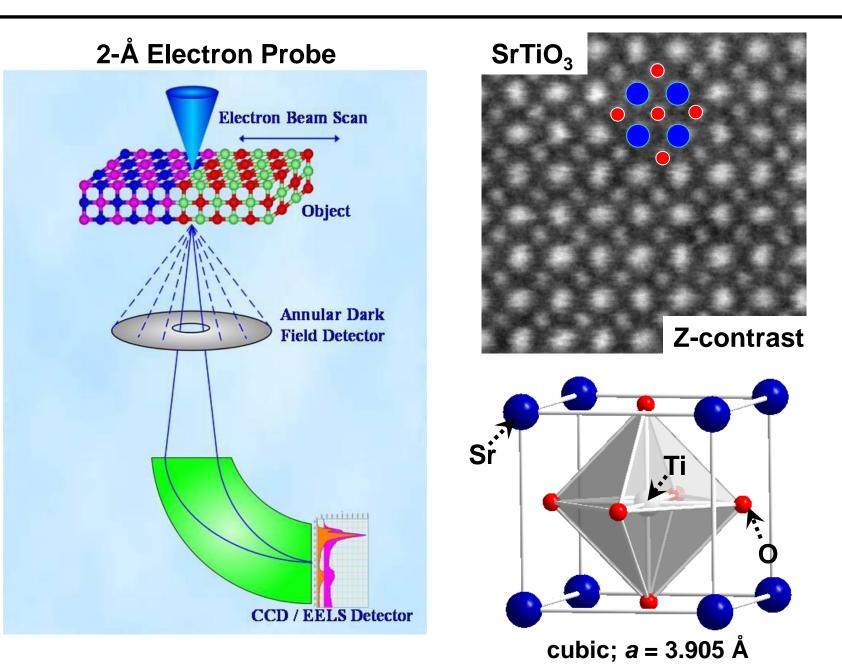


• Determining the interface location and sharpness is easy.

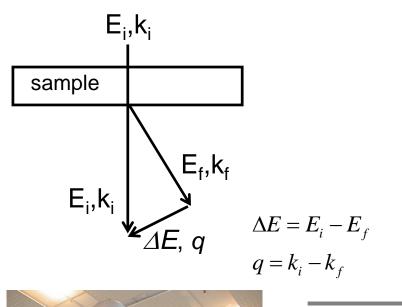
• The *In*-distribution seems to be inhomogeneous in the InAIAs

Note that InP substrate is In-

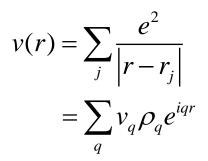
#### Atomic Resolution STEM Imaging: Z-contrast



#### Electron Energy-Loss Spectroscopy (EELS)



#### **Coulomb Interaction**



, where  $\rho_q$  the electron density operator



Inelastic Scattering (
$$\Delta E$$
) Probability  

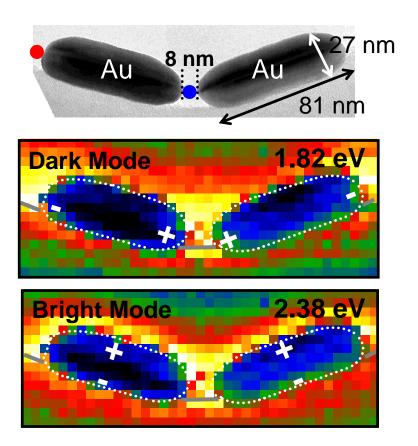
$$\frac{d^{2}\sigma}{d\Omega d\Delta E} \sim \sum_{f} \left| \langle \psi_{f} | v(q) | \psi_{i} \rangle \right|^{2} \delta(E_{i} - E_{f} - \Delta E)$$

$$\sim \frac{1}{q^{4}} \cdot S(\omega, q) \longrightarrow X\text{-ray}$$

$$\sim \frac{1}{q^{2}} \cdot \operatorname{Im} \left[ \frac{1}{\varepsilon(\omega, q)} \right] \longrightarrow \text{EELS}$$

#### **Spectral Imaging at Ultimate Spatial Resolution**

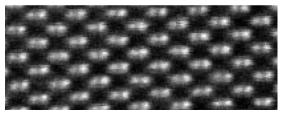
#### Plasmonic Mapping: STEM-EELS (2-Å Probe)

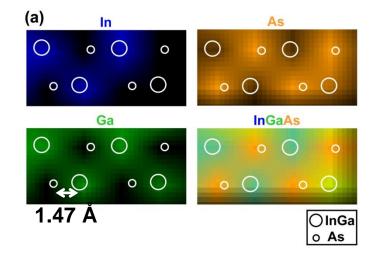


M.-W. Chu et al., Nano Lett. 9, 399 (2009).

Chemical Mapping: STEM-EDX (1-Å Probe)

#### InGaAs





M.-W. Chu et al., Phys. Rev. Lett. 104, 196101 (2010).

## **The Third Lesson:**

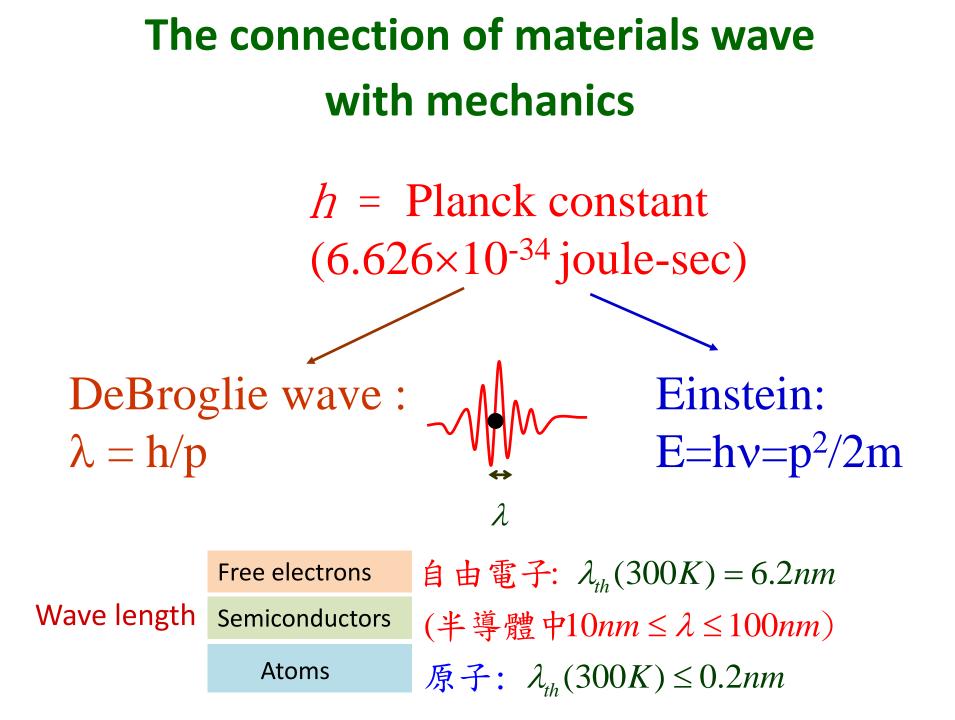
The importance of Quantum Physics

#### The cause for variation of scaling

- Influence of Boundary
  - --Increase of proportion of boundaries
  - --Existence of surface / edge modes
  - --Geometrical reconstruction
- Decrease of the number of particles decrease of confinement, increase of perturbation
- Different scaling for different physical entity

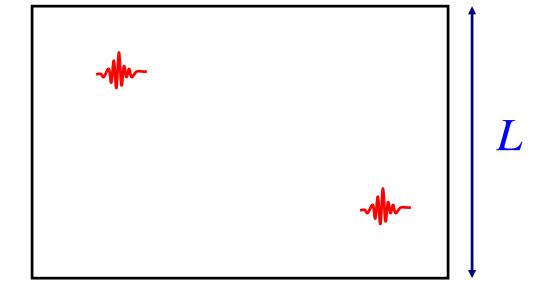
#### **Quantum Effect:**

=> Most likely to have new breakthrough !



## Bulk Limit 🖨 Nano Limit

For bulk materials λ << L



For nano materials λ~L

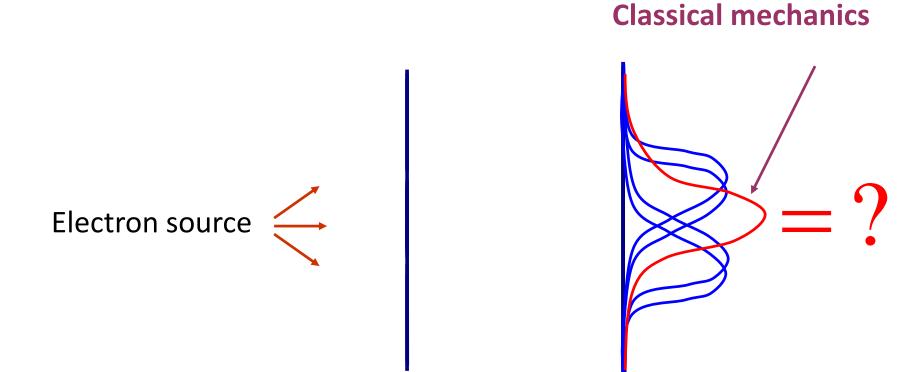


Major Quantum Effects at the Nano Scale

- Interference
- Quantization
- Tunneling
- Quantum spin

## **(I)** Interference

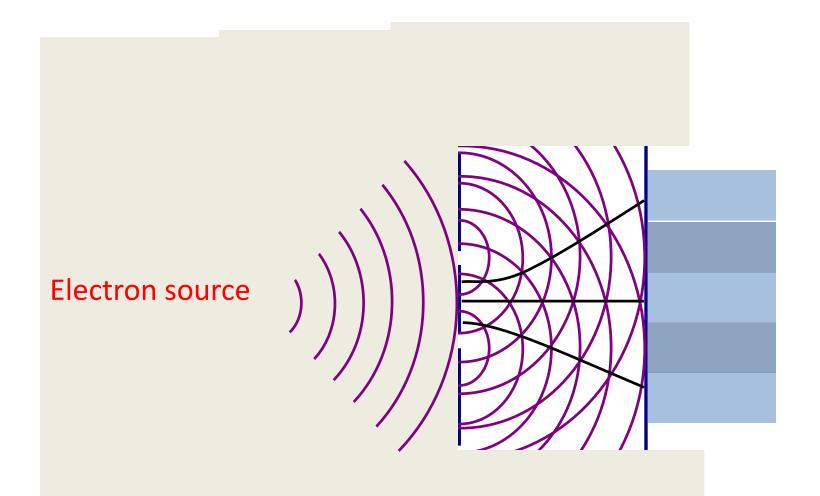
## The wonder of electron in waves

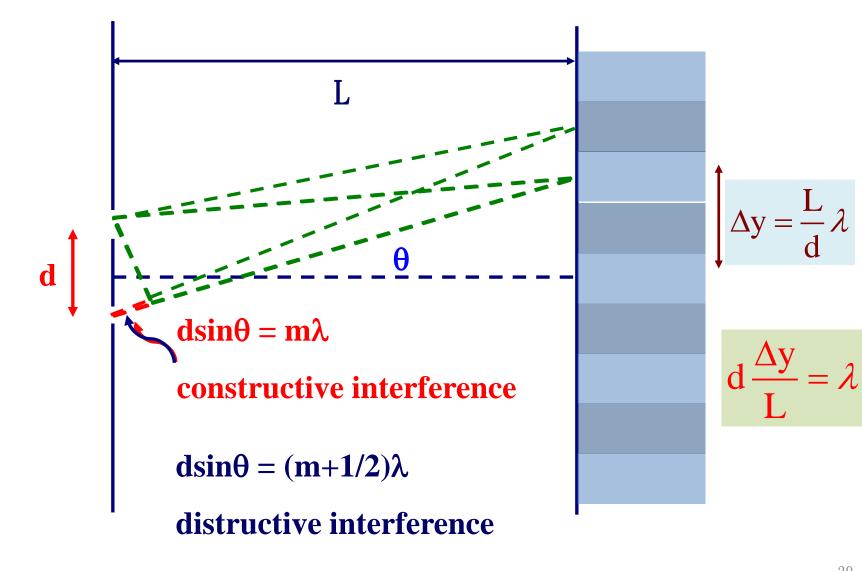


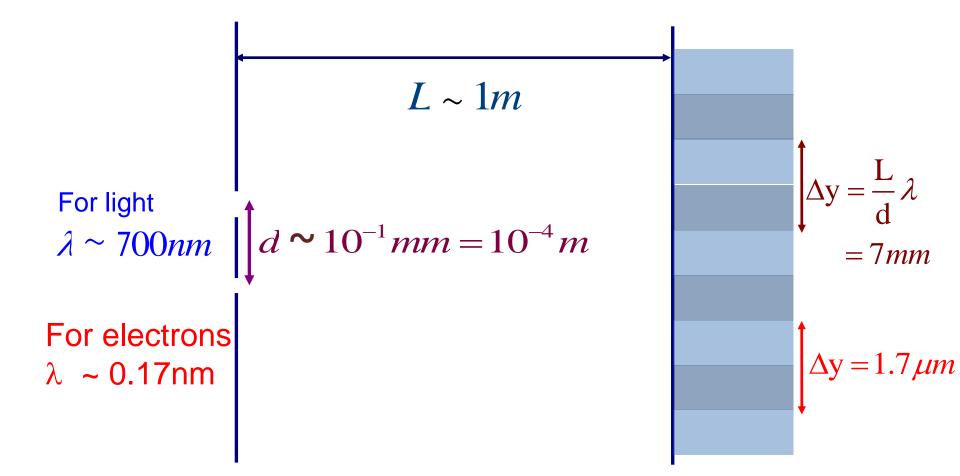
## The wave property of electrons

when we XIVINLA

## **Double Slit Interference of Electrons**







## (II) Quantization

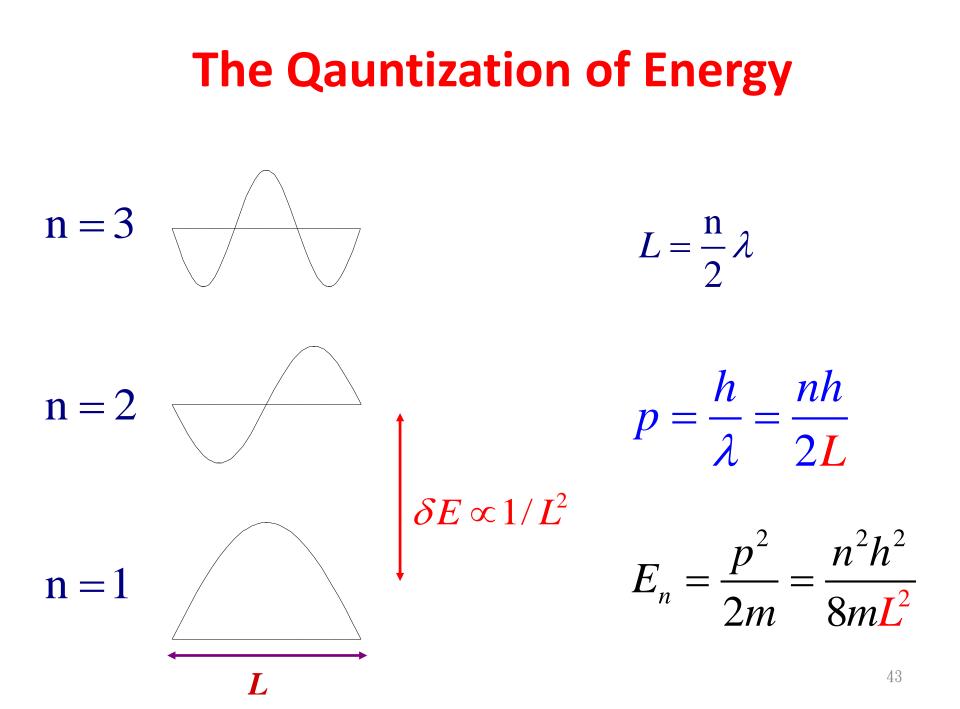
#### **Confinement of the materials wave**



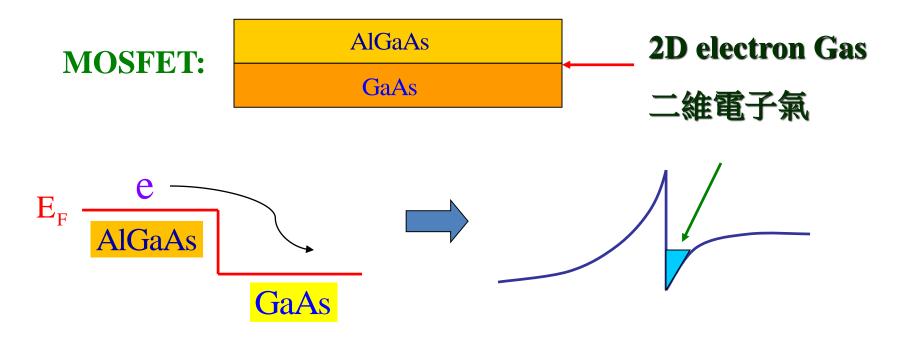
#### **Standing Wave**



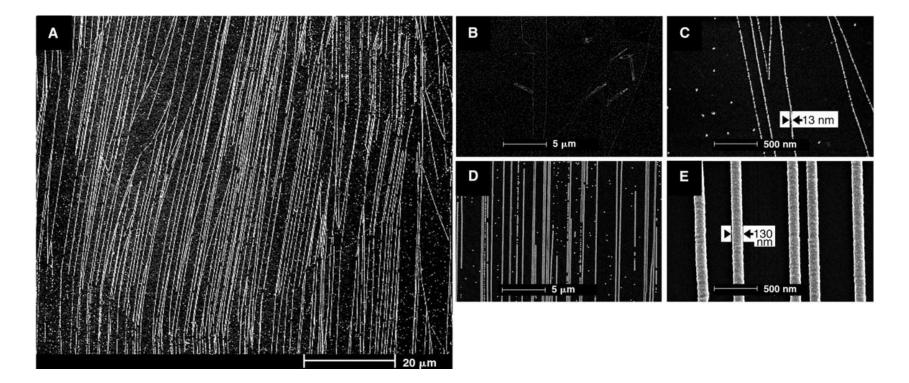
**Quantizations** 



## **Quantum well: 1D confinement**



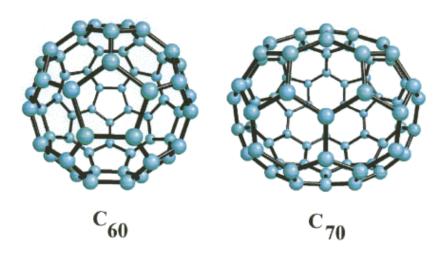
## **Quantum wire: 2 D-Confinement**



SEM images of MoO<sub>x</sub> nanowires on graphite surfaces

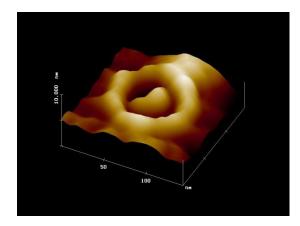
Science **290**, 2120-2123, (2000).

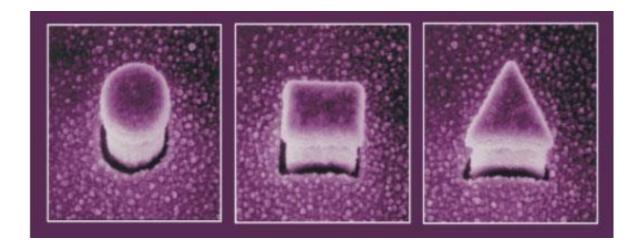
## Quantum dot: 3D - Confinement



Smalley et al, Rice Univ, (1985)

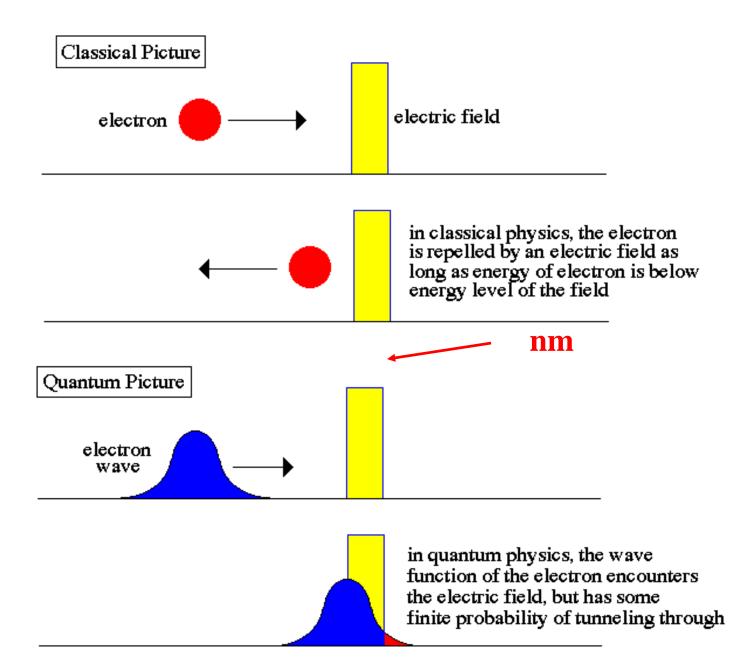
## **Quantum Dots of various shape**



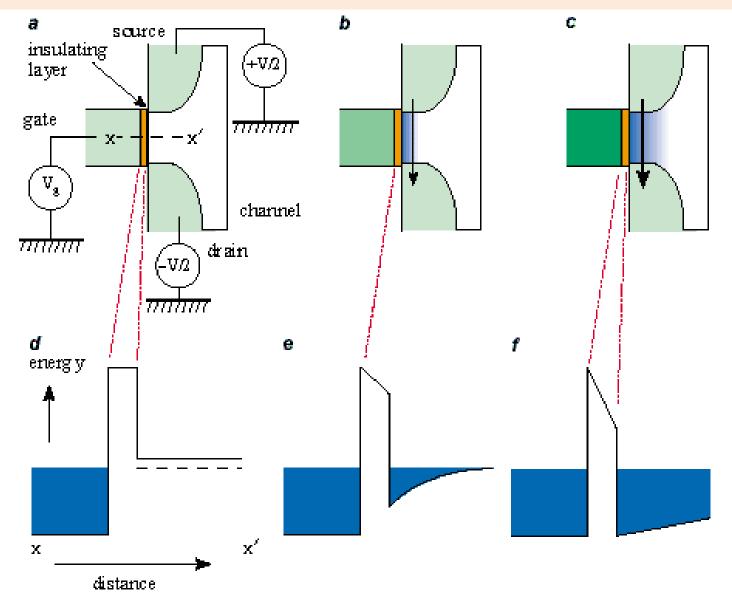


Absorption in scattering from red to yellow  $\lambda \quad i = hc / \lambda \propto 1 / L^2$  $\lambda_0$ larger **powdered CdSe (Cadium Selenide)** larger smaller

(III) Tunneling and Nano-electronics



# Quantum tunneling is the major effect for the failure of transistor at nano scale

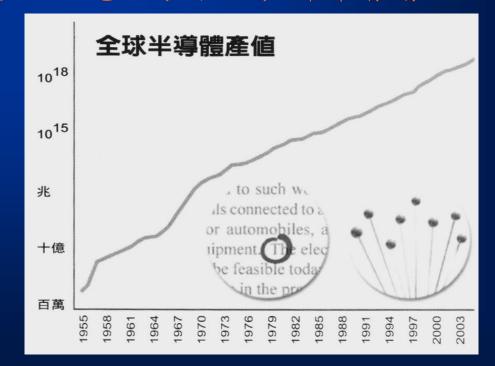


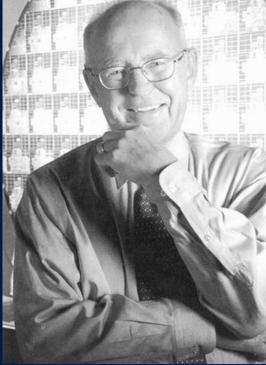
51



## 近來大力推動奈米科技的背景

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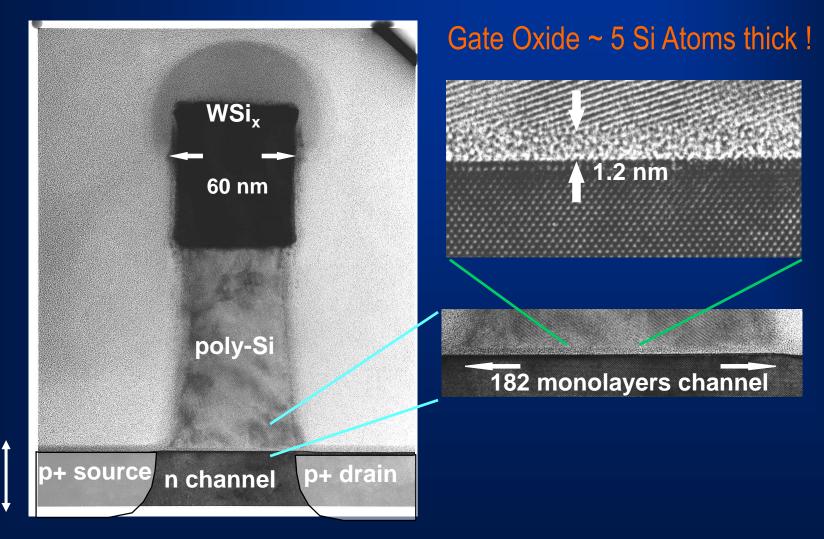




**Gordon Moore** 



## Scaling Limits to CMOS Technology



Shrinking the junction depth increasing the carrier concentration



**Reliability: 2**5 **22** 18 16 Å?

processing and yield issue

Tunneling: 15 Å

Design Issue: chosen for  $1A/cm^2$  leakage  $I_{on}/I_{off} >> 1$  at 12 Å

#### **Bonding:**

Fundamental Issues---

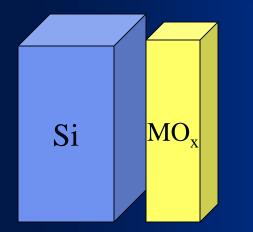
- how many atoms do we need to get bulk-like properties?
   EELS -- Minimal 4 atomic layers !!
- Is the interface electronically abrupt?
- Can we control roughness?

In 1997, a gate oxide was 25 silicon atoms thick.

In 2007, a gate oxide will be 5 silicon atoms thick, if we still use  $SiO_2$ 

and at least 2 of those 5 atoms will be at the interfaces.

## Fundamental Materials Selection Guidelines



 $Si + MO_{x} \longrightarrow M + SiO_{2}$   $Si + MO_{x} \longrightarrow MSi_{2} + SiO_{2}$   $Si + MO_{x} \longrightarrow MSiO_{x} + SiO_{2}$ 

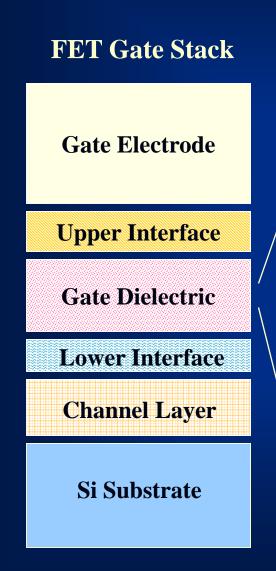
Thermodynamic stability in contact with Si to 750°C and higher. (Hubbard and Schlom) Alkaline earth oxide, IIIB, IVB oxide and rare earth oxide

- Dielectric constant, band gap, and conduction band offset
- Defect related leakage, substantially less than
  - $SiO_2$  at  $t_{eq} < 1.5$  nm
- Low interfacial state density  $D_{it} < 10^{11} \text{ eV}^{-1} \text{ cm}^{-2}$
- Low oxygen diffusivity
- Crystallization temperature >1000°C
- $t_{eq}$ : equivalent oxide thickness (EOT) to be under 1.0 nm  $t_{eq} = t_{ox} \kappa_{SiO2} / \kappa_{ox}$

## **Basic Characteristics of Binary Oxide Dielectrics**

| Dielectrics   | SiO <sub>2</sub>     | Al <sub>2</sub> O <sub>3</sub> | Y <sub>2</sub> O <sub>3</sub> | HfO <sub>2</sub> | Ta <sub>2</sub> O <sub>5</sub> | ZrO <sub>2</sub>  | La <sub>2</sub> O <sub>3</sub> | TiO <sub>2</sub>        |
|---|----------------------|--------------------------------|-------------------------------|------------------|--------------------------------|-------------------|--------------------------------|-------------------------|
| Dielectric constant   | 3.9                  | 9.0                            | 18                            | 20               | 25                             | 27                | 30                             | 80                      |
| Band gap (eV)<br>Band offset (eV)   | 9.0<br>3.2           | 8.8<br>2.5                     | 5.5<br>2.3                    | 5.7<br>1.5       | 4.5<br>1.0                     | 7.8<br>1.4        | 4.3<br>2.3                     | <mark>3.0</mark><br>1.2 |
| Free energy of formation<br>MO <sub>x</sub> +Si <sub>2</sub> → M+ SiO <sub>2</sub><br>@727C, Kcal/mole of MO <sub>x</sub> | -                    | 63.4                           | 116.8                         | 47.6             | -52.5                          | 42.3              | 98.5                           | 7.5                     |
| Stability of amorphous phase  | High                 | High                           | High                          | Low              | Low                            | Low               | High                           | High                    |
| Silicide formation ?  | -                    | Yes                            | Yes                           | Yes              | Yes                            | Yes               | Yes                            | Yes                     |
| Hydroxide formation ?   | -                    | Some                           | Yes                           | Some             | Some                           | Some              | Yes                            | Some                    |
| Oxygen diffusivity<br>@950C (cm <sup>2</sup> /sec)  | 2x 10 <sup>-14</sup> | 5x 10 <sup>-25</sup>           | 5                             | 5                | Ş                              | 10 <sup>-12</sup> | Ş                              | 10 <sup>-13</sup>       |

## Integration Issues for High K Gate Stack



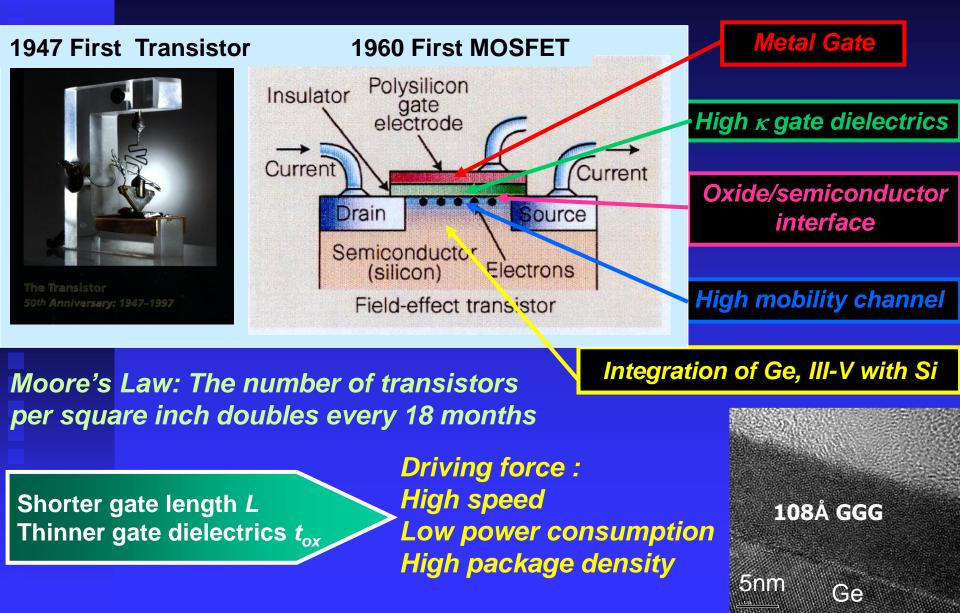
## **Critical Integration Issues**

- Morphology dependence of leakage *Amorphous vs crystalline films?*
- Interfacial structures
- Thermal stability
- Gate electrode compatibility
- Reliability

#### **Fundamental Limitations**

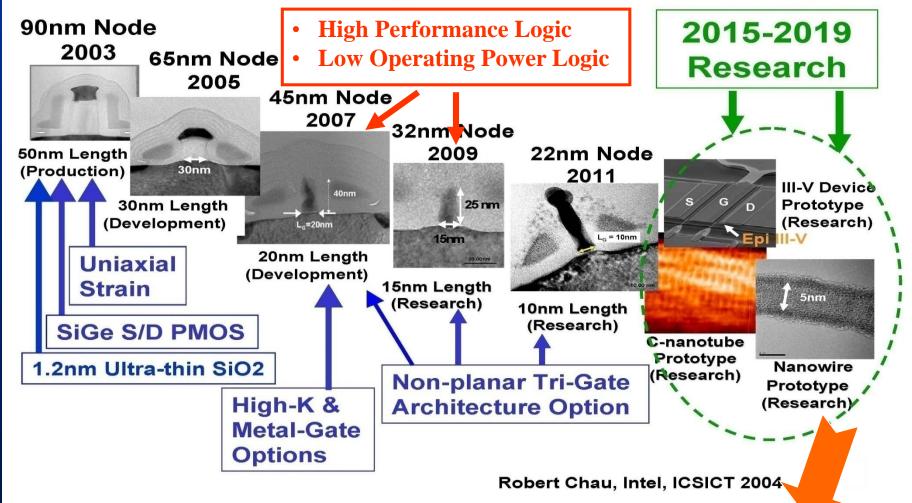
- Fixed charge
- Dopant depletion in poly-Si gate
- Dopant diffusion
- Increasing field in the channel region

#### **Si** CMOS Device Scaling – Beyond 22 nm node High κ, Metal gates, and High mobility channel



## **Intel Transistor Scaling and Research Roadmap**

#### **Transistor Scaling and Research Roadmap**

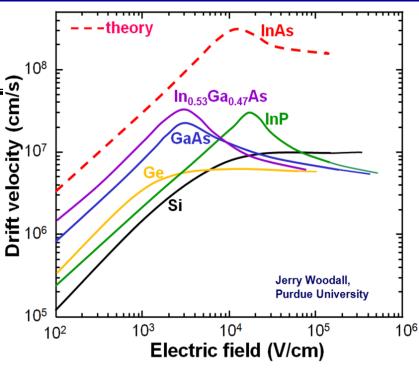


More non-silicon elements introduced





## Why III-V MOSFETs?



#### **III-V semiconductors**

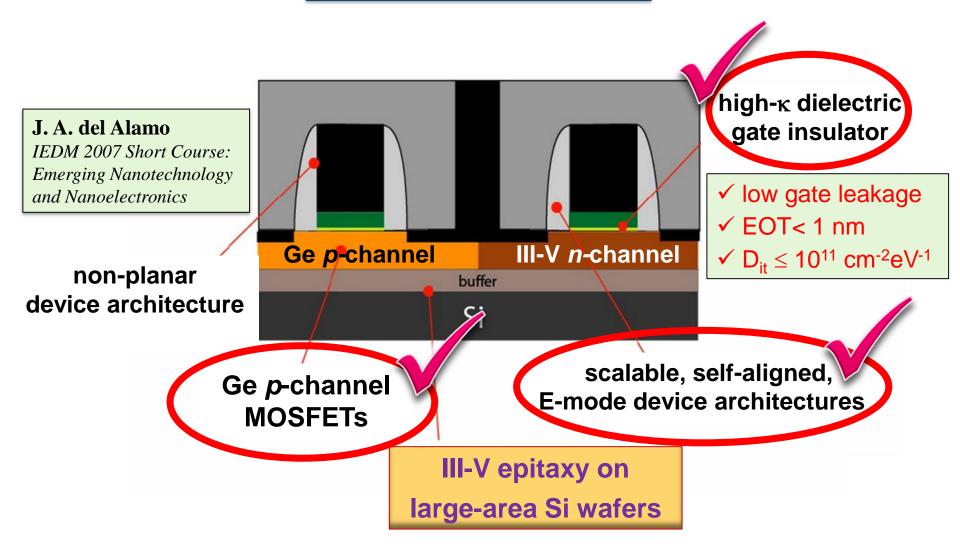
- high electron mobility/drift velocity
- sophisticated band-gap engineering
- → improved power/performance tradeoff
- $\checkmark$  high frequency or optical applications
- ✓ substantial manufacturing experience

#### High-κ / III-V MOSFETs

◆ Schottky gate (MESFET/HEMT) → MOS gate
 → reduced gate leakage

|                                | ľ     | V     | III-V |  |        |      |        |  |  |  |
|--------------------------------|-------|-------|-------|--|--------|------|--------|--|--|--|
|                                | Si    | Ge    | GaAs  | In <sub>0.53</sub> Ga <sub>0.47</sub> As | InAs   | GaSb | InSb   |  |  |  |
| Electron Mobility<br>(cm²/V·s) | 1,400 | 3,900 | 8,500 | 12,000                                   | 40,000 | 3000 | 77,000 |  |  |  |
| Hole mobility<br>(cm²/V·s)     | 450   | 1,900 | 400   | 450                                      | 500    | 1000 | 850    |  |  |  |
| Bandgap (eV)                   | 1.11  | 0.67  | 1.42  | 0.74                                     | 0.36   | 0.72 | 0.17   |  |  |  |

## The Grand Challenges for III-V/Ge CMOS

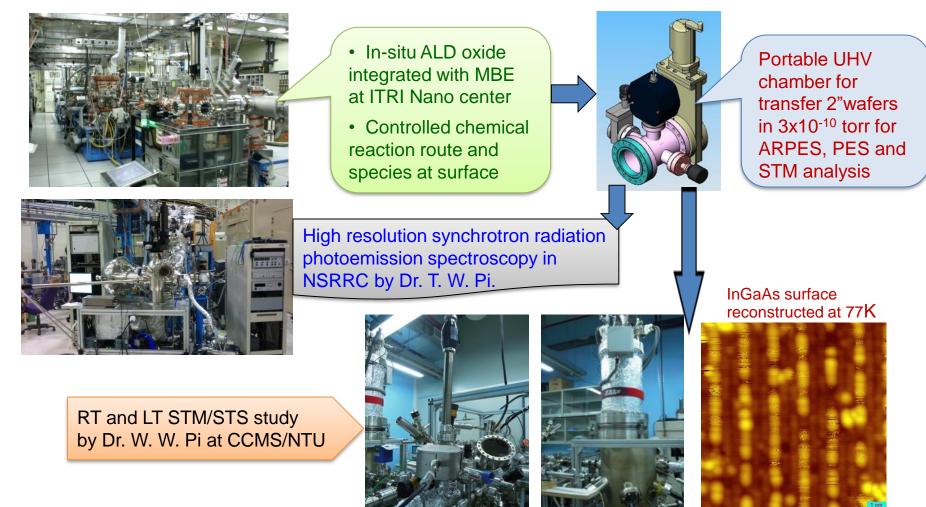


#### Science and Technology of Ultimate CMOS

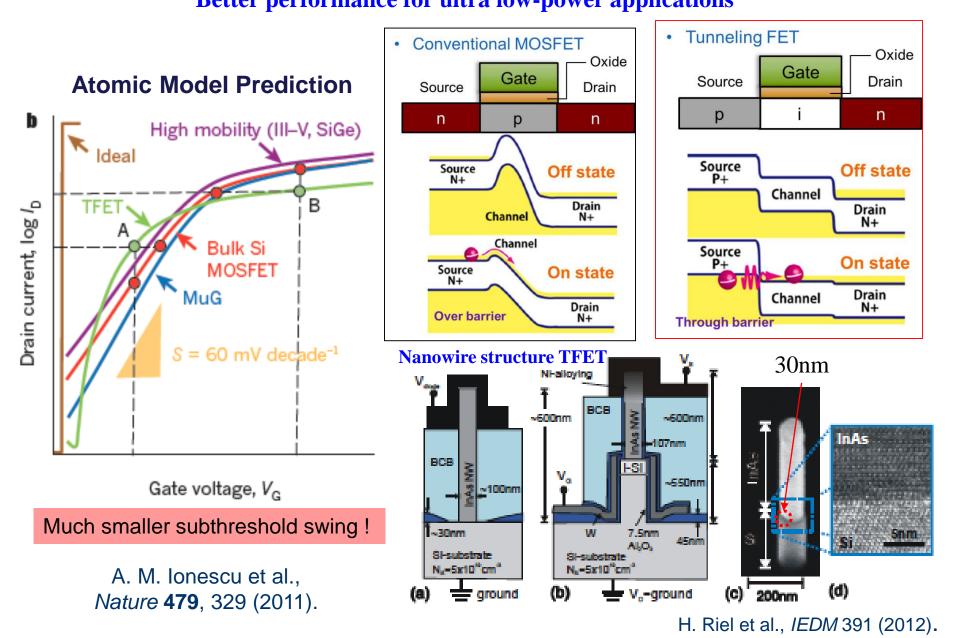
#### The Ultimate CMOS – End of road map

#### To achieve higher speed and lower power consumption

R&D of III-V InGaAs MOSFET *state-of-art* technology below 5 nm node, by combining advanced analysis of spectroscopy/microscopy/quantum transport/theoretical modeling



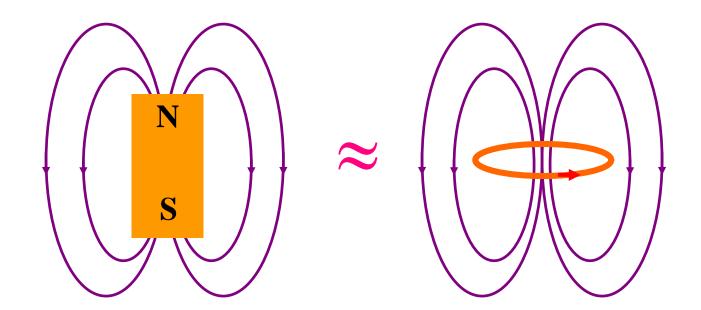
## Tunneling-FETs offer sharper turn-on devices compared to MOSFETsLower V<sub>DD</sub> to lower switching energy (Pactive ~C · VDD<sup>2</sup>)Better performance for ultra low-power applications



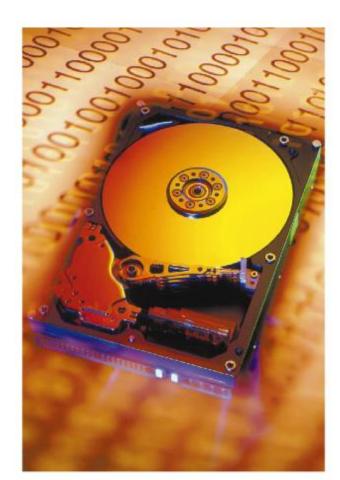
## (IV) Quantum Spin

## Spin and Nano technology

## Electron Spin is the smallest unit of magnetism, came from Quantum Mechanics



## Often being used for magnetic recording ~30 billion market

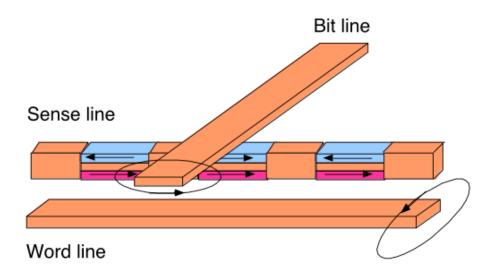


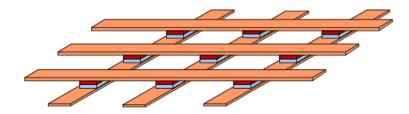
Well read: spintronics has dramatically increased data storage densities in hard drives.

## Spintronics $\Leftrightarrow$ Electronics

## New generation of computer

#### **Computation and storage in one shot**



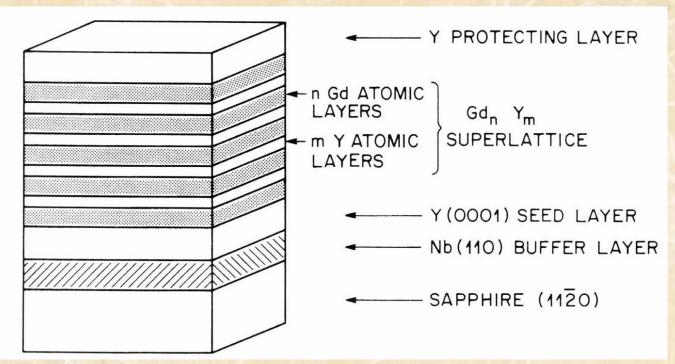


**Fig. 7.** A schematic representation of RAM that is constructed of magnetic tunnel junctions connected together in a point contact array. The conducting wires provide current to the junctions and permit voltage measurements to be made. They also enable the manipulation of the magnetization of the elements by carrying currents both above and below the magnetic junctions to create magnetic fields.

When turn-on, it is ready!

## **Artificial Superlattice**

--- Matching the structural periodicity with physical length scale of superconductivity and magnetism -- Modulation of physical properties



Invention of metal molecular beam epitaxy in 1981 -- Single crystal epitaxial superlattices with atomically abrupt interfaces

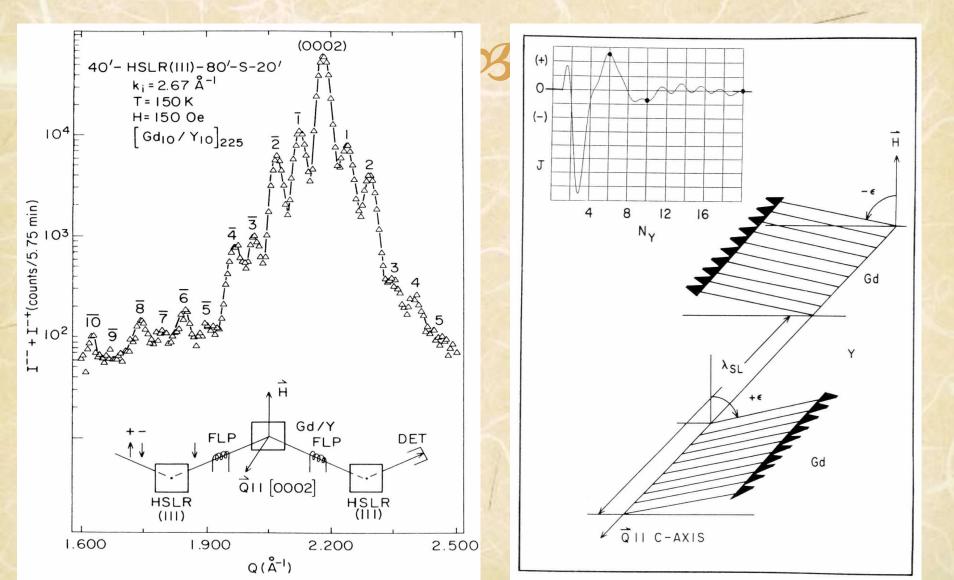
Caxis 0001 Tm Dy Gd, Dy

Spin structures of heavy rare - earths

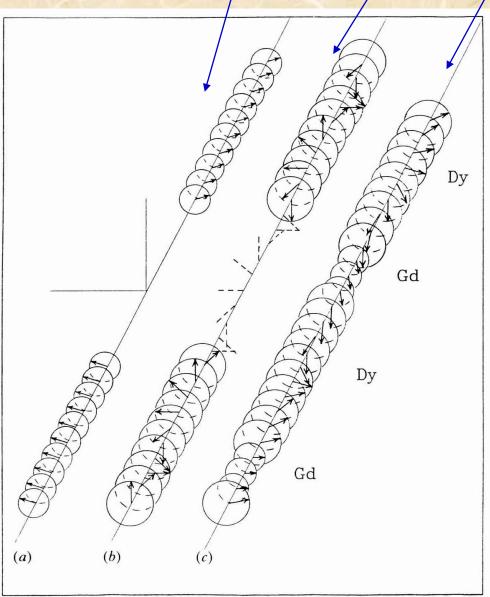
## **HCP crystal structure**

- Similar crystal- chemical nature of rare earths form coherent superlattices
- Metallic superlattice effect
  - Long range nature of the indirect exchange interaction
  - Magnetic coupling of magnetic rare earth through non magnetic Y, Lu
  - Modulation of magnetic properties of Gd - Y Superlattices
  - Spin structure modification of Tm Y, Dy - Y Superlattices
- 2-dimensional magnetism
- Interfacial magnetism

#### Neutron Diffraction Studies of the Gd<sub>10</sub>-Y<sub>10</sub> Magnetic Superlattice Antiferromagnetically coupled below 200K



### Spin Structure Tailoring in artificial Superlattices Gd-Y Dy-Y Gd-Dy

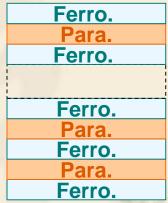


Year 1984-1989

# Giant Magnetoresistance (GMR)

#### What is GMR?

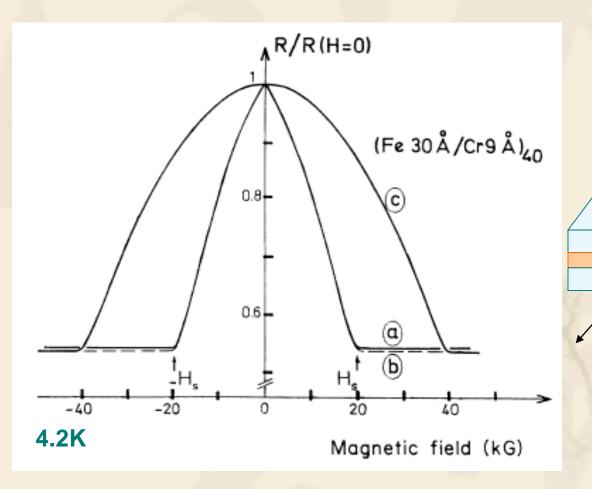
- GMR is a very large change in electrical resistance that is observed in a ferromagnet/paramagnet multilayer structure.
- Resistance change occurs when the relative orientations of the magnetic moments in alternate ferromagnetic layers change as a function of applied field.



The total resistance of this material is lowest when the magnetic orientations of the ferromagnetic layers are aligned, is highest when the orientations are anti-aligned.

M. N. Baibich, J. M. Broto, A. Fert, F. Nguyen Van Dau, and F. Petroff, *Phys. Rev. Lett.*, **61**, 2472 (1988).

# First Evidence of GMR



 $H_s$  corresponds to the field at which all layer magnetizations point along the field direction.

Fe

Cr

Fe

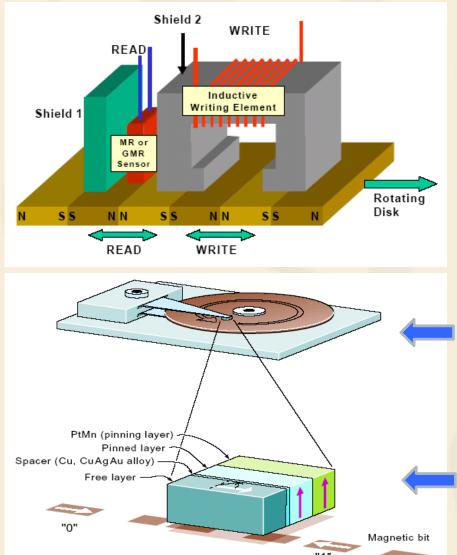
# **Spin-Valve GMR**

The simple structure of Spin-Valve GMR :



The magnetization of the top permalloy layer is free to rotate as the field is varied. The second permalloy layer is fixed due to its exchange interaction with the FeMn layer.

### GMR Spin Valve Reading Head

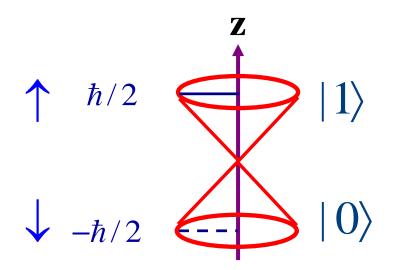


When the head passes over these magnetic bits, the magnetization direction of the free layer in the head responds to the field in each bit by rotating either up or down.

The resulting change in the resistance is sensed by the voltage across the GMR head (current passing through the GMR element is constant).

Dr. K. Gilleo, Cookson Electronics ; N. Kerrick and G. Nicholls, AMPM

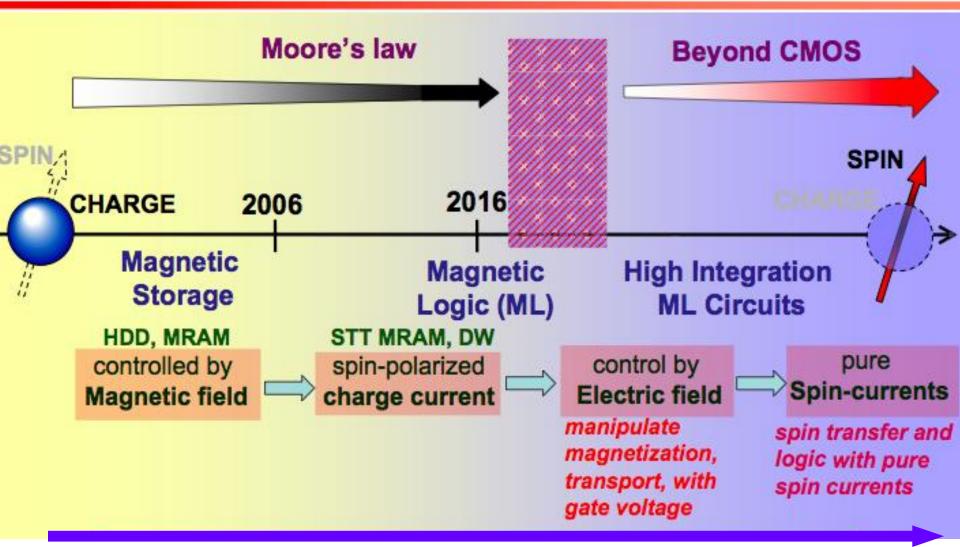
# Quantum behavior of ferromagnets -Spin as a quantum qubit



 $qubit = \alpha | 0 \rangle + \beta | 1 \rangle$ 

**Due to superposition More information!** 

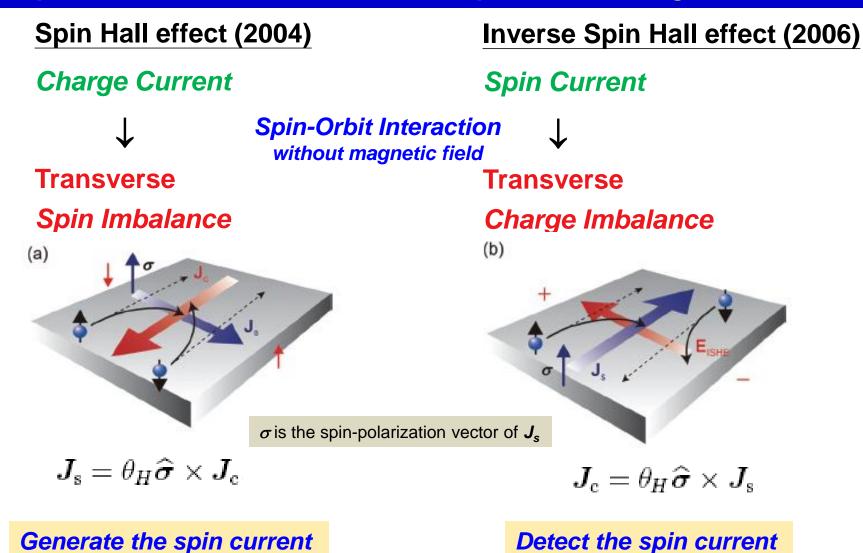
### **Tentative roadmap**



#### Can we take the "charge" out of Spintronics ? To generate pure spin current !

Courtesy Claude Chappert Université Paris Su INTERMAG 2008 Madrid Spain

#### Reciprocal conversion between spin and charge currents



Y. K. Kato, R. C. Myers, A. C. Gossard, and D. D. Awschalom, Science, 306, 1910 (2004). ; J. Wunderlich, B. Kaestner, J. Sinova, and T. Jungwirth, Phys. Rev. Lett. 94, 047204 (2005). ; E. Saitoh, M. Ueda, H. Miyajima, and G. Tatara, Appl. Phys. Lett, 88, 182509, (2006).



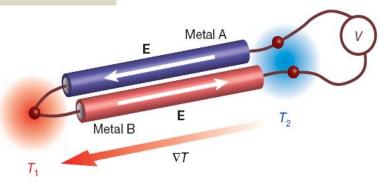
- Reducing the heat generated in traditional electronics is a major driving force for developing spintronics.
- Spin-based transistors do not strictly rely on the raising or lowering of electrostatic barriers, hence it may overcome scaling limits in charge-based transistors.
- Spin transport in semiconductors may lead to dissipationless transfer of information by pure spin currents.
- Allow computer speed and power consumption to move beyond limitations of current technologies.

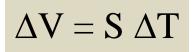
### Reliable generation of pure spin currents!

- ✓ Spin Hall effect (2004)
- ✓ Spin Pumping (2006)
- ✓ Inverse Spin Hall effect (2006)
- ✓ Spin Seebeck effect (2008)
- ✓ Spin Caloritronics (2010)

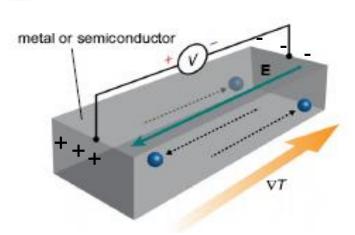
### Thermoelectric effect

- The interplay between charge currents and heat
- To convert temperature differences  $\Delta T$  to electric voltage  $\Delta V$
- 1. Thermocuple



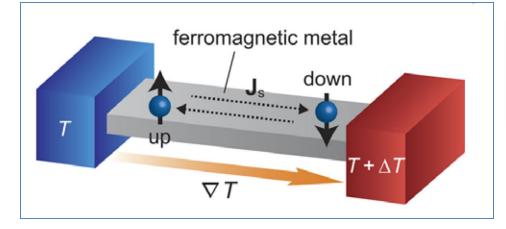


2. Seebeck effect (1821)



 $\Delta T \rightarrow V$ S =  $\Delta V / \Delta T$ S: Seebeck Coefficient

#### Spin Seebeck effect: the interplay between spin current and heat



Generation of a "spin voltage" as a result of a temperature gradient in magnetic materials

$$\delta V_{spin} = S_{spin} \delta T$$

 $\nabla T \implies a \text{ spin imbalance}$ 

The up- spin and down-spin conduction electrons of a FM metal have different chemical potential  $\mu$ , with different scattering rate and density, thus result in  $J_{\uparrow}$  and  $J_{\downarrow}$  of different amount.  $S_{spin} = (1/e)[\partial \mu_{\uparrow} / \partial T - \partial \mu_{\downarrow} / \partial T]$ 

■  $J_{\uparrow}$  and  $J_{\downarrow}$  flow in opposite directions along  $\nabla T$ , and lead to a net  $J_s$ 

$$\boldsymbol{j}_s = \boldsymbol{j}_{\uparrow} - \boldsymbol{j}_{\downarrow} = (\boldsymbol{\sigma}_{\uparrow} \boldsymbol{S}_{\uparrow} - \boldsymbol{\sigma}_{\downarrow} \boldsymbol{S}_{\downarrow})(-\nabla \boldsymbol{T})$$

This pure spin current flows without charge current in open-circuit condition.

Use heat to generate the spin current  $\rightarrow$  Spin Caloritronics ! >

K. Uchida et al., Nature, **455**, 778, (2008).

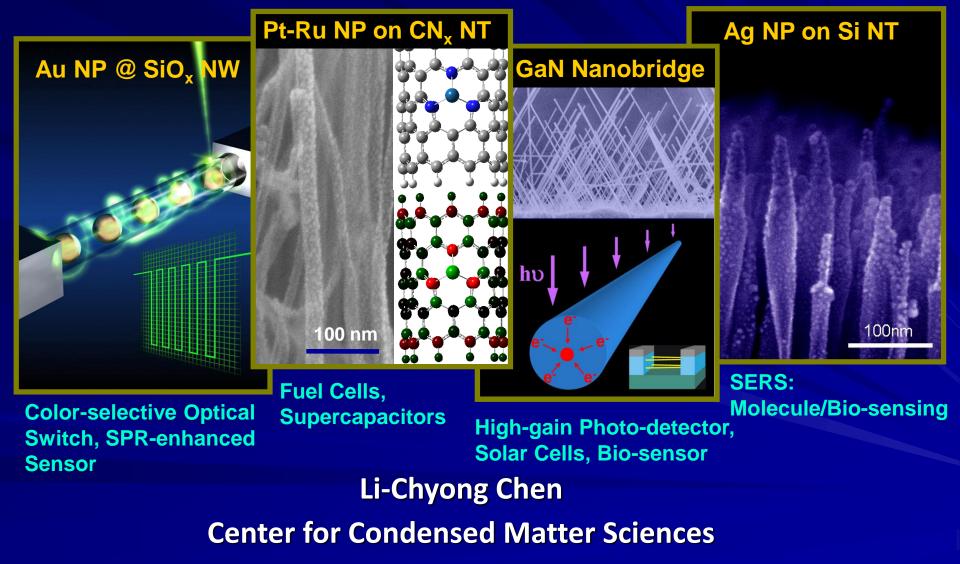
Major Quantum Effect at the Nano Scale

- Interference
- Quantization
- Tunneling
- Quantum spin

# **The Fourth Lesson:**

# Innovations of nano structures and nano materials for various applications

### **Overview of Advanced Materials Laboratory**



**National Taiwan University** 

### The Nano-world at CCMS-AML: a Fruitful Research Field with Technology Implications

JACS 123, 2791 (2001) APL 81, 22 (2002) JACS 127, 2820 (2005) APL 88, 241905 (2006) APL 90, 213104 (2007) Adv. Func. Mater. 18, 938 (2008) Small 4, 925 (2008) Analytical Chem. 81, 36 (2009)

APL 79, 3179 (2001) APL 81, 4189 (2002) Adv. Func. Mater. 12, 687 (2002) APL 86, 203119 (2005) Chem. Mater. 17, 3749 (2005) JACS 128, 8368 (2006) PRB 75, 195429 (2007) JACS 130, 3543 (2008)

Chapter 9, pp. 259-309, Nanowires and nanobelts, Z.L. Wang Ed., Kluwer (2004) Adv. Func. Mater. 16, 537 (2006) APL 90, 123109 (2007) Adv. Mater. 19, 4524 (2007)



Adv. Mater. 14, 1847 (2002) Nature Mater. 5, 102 (2006)

### Wire/Rod

Tube

**Belt** 

Peapod

Nanotip

APL 83, 1420 (2003) Nano. Lett. 4, 471 (2004) Chem. Mater. 17, 553 (2005) Adv. Func. Mater. 15, 783 (2005) APL 86, 203119 (2005) US Patent 6,960,528,B2 APL 89, 143105 (2006) Nature Nanotech. 2, 170 (2007) Nano Lett. 9, 1839 (2009)

**Core-shell** 

Brush

APL 81, 1312 (2002) Nano. Lett. 3, 537 (2003)

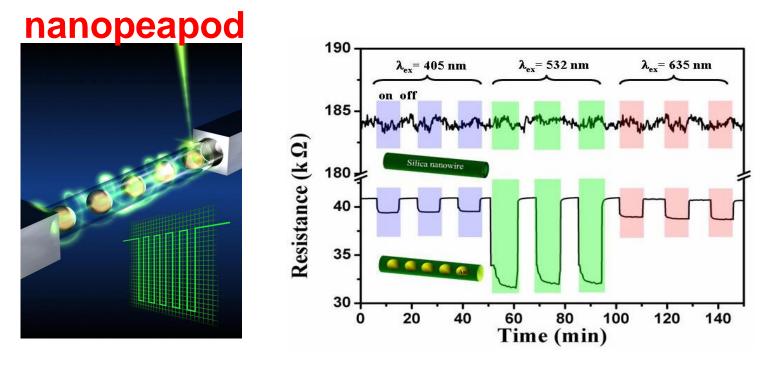
Adv. Func. Mater. 14, 233 (2004)

Other Thin Films: APL 86, 21911 (2005) APL 86, 83104 (2005) APL 86, 161901 (2005) APL 87, 261915 (2005) JVST B 24, 87 (2006) APL 88, 73515 (2006) Adv. Mater. 21, 759 (2009)

#### A Color-selective Nanoswitch

#### Photosensitive Gold Nanoparticle-embedded Dielectric Nanowires

M. S. Hu, et al., Nature Materials 5, 102-106 (2006)

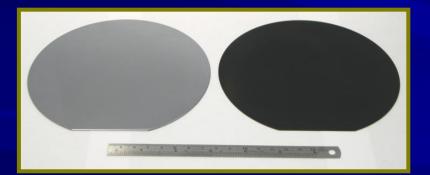


In ancient Arabian story of "Ali Baba and the Forty Thieves", the treasure is in a cave, of which the mouth is sealed by magic. It opens on the words "Open Sesame" and seals itself on the words "Close Sesame".

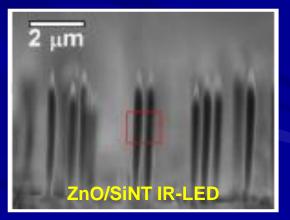
The **nanopeapod** (i.e., gold nanoparticle-embedded dielectric nanowire) will open to green light, but shut for lights of other colors.

Si Nanotips-Array and their Hetero-junctions: On-chip, IC-compatible

- \* Antireflection: Broadband (UV-terahertz), Omnidirectional (>70°)
- \* Electroluminescence in ZnO/SiNTs: IR emission, x10 higher; turn-on ~3V, x2 lower than film



Nature-Nanotechnology 2 (2007) 770

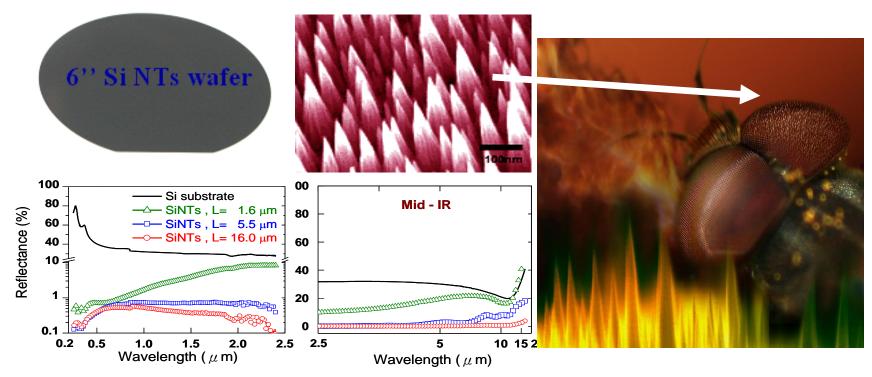


Nano Letters 9 (2009) 1839

A Man-made Moth Eye

# Broadband and quasi-omni-directional, anti-reflection properties with biomimetic Silicon nanostructure

Y. F. Huang, et al., Nature Nanotechnology 2, 770-774 (2007) & US Patent 2005

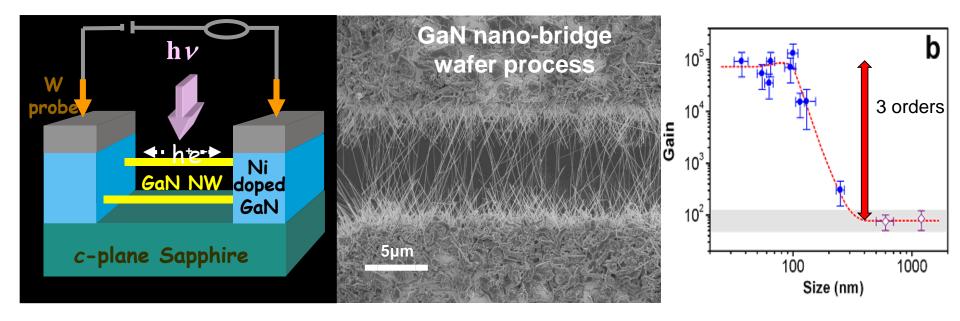


Many plants and animals have tiny surface structures that absorb certain wavelengths of light. These naturally formed nanostructures provide the colors in butterfly wings, camouflage for cicadas and enable moths to capture as much light as possible when flying at night. Now, we have created nanostructure surfaces which mimic moth eye and surpass its function in **anti-reflection** in that they absorb almost all incident light.

#### Building a Nano-scale Bridge On-chip

#### On-chip Fabrication of Well Aligned and Contact Barrier-Free GaN Nanobridge Devices with Ultrahigh Photocurrent Responsivity

R. S. Chen, et al., Small 4, 925-929 (2008)



- Nanowire: Naturally formed core-shell structure, 1D electron gas-like property
- On-chip process for building **GaN nanobridge devices**, which provide a large surface area, short transport path, and high responsivity for next-generation sensors and detectors

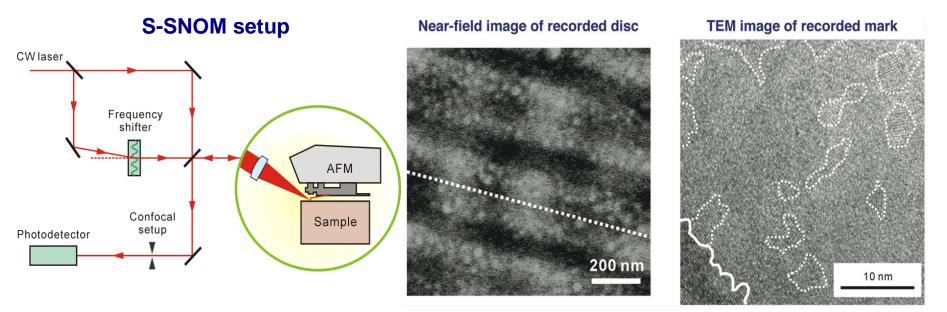
# **The Fifth Lesson:**

# Nano photonics and

**Bio-applications** 

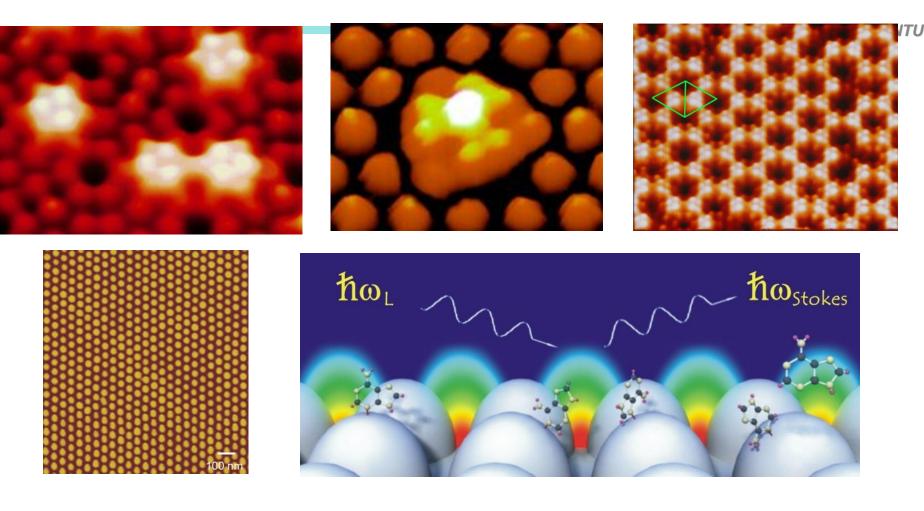
### Nano-photonics and Plasmonics Near-field examination of blue-ray discs

Dr. Juen-Kai Wang, CCMS, NTU



- Scattering-type SNOM reveals sub-10 nm optical signature.
- The optical contrasts of the dark and the bright regions in near-field image of phasechange layer correspond to amorphous and polycrystalline AgInSbTe, respectively.
- Small bright spots with a size of ~30 nm emerge within the dark region, corresponding to the nano-sized ordered domains in the TEM image.
- s-SNOM provides a direct optical probe in nanometer scale for high density optical storage media.
- J. Y. Chu et al., Appl. Phys. Lett. 95, 103105 (2009).

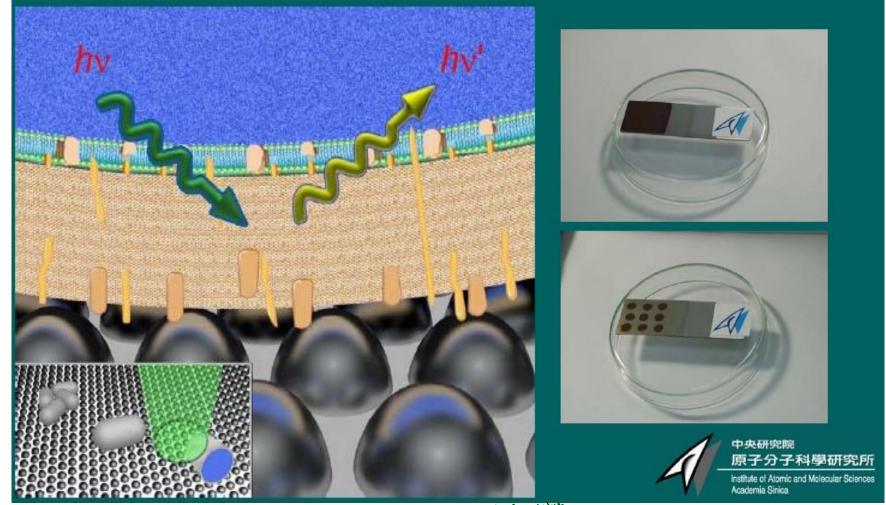
#### **Creating Monodispersed Ordered Arrays of Surface-Magic-Clusters and Anodic Alumia Nanochannels by Constrained Self-organization**



Prof. Yuh-Lin Wang 王玉麟 IAMS Academia Sinica, Taiwan

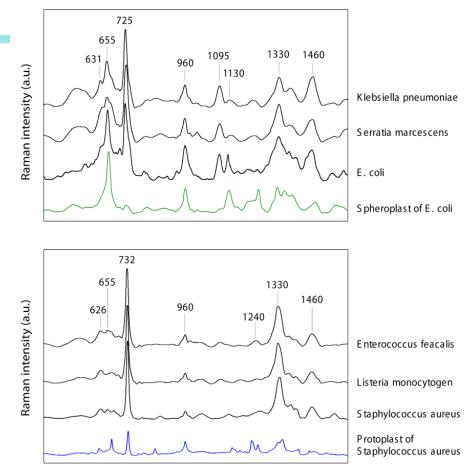
#### A High Sensitivity and High Speed Biomedical Diagnostic Technology with Surface Enhanced Raman Scattering (SERS)

Dr. Juen-Kai Wang, CCMS, NTU

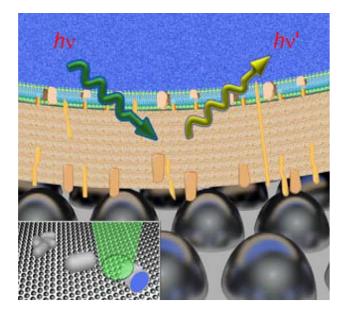


Prof. Yuh-Lin Wang 王玉麟 IAMS Academia Sinica, Taiwan

### **SERS detection of bacterial cell wall**



Dr. Juen-Kai Wang, CCMS, NTU



- Sensitive and stable SERS profiles based on our substrates readily reflect different bacterial cell walls found in Gram-positive, Gram-negative, and mycobacteria group.
- Characteristic changes in SERS profile are recognized in the *drug-sensitive* bacteria to antibiotic exposure, which could be used to differentiate them from the *drug-resistant* ones.

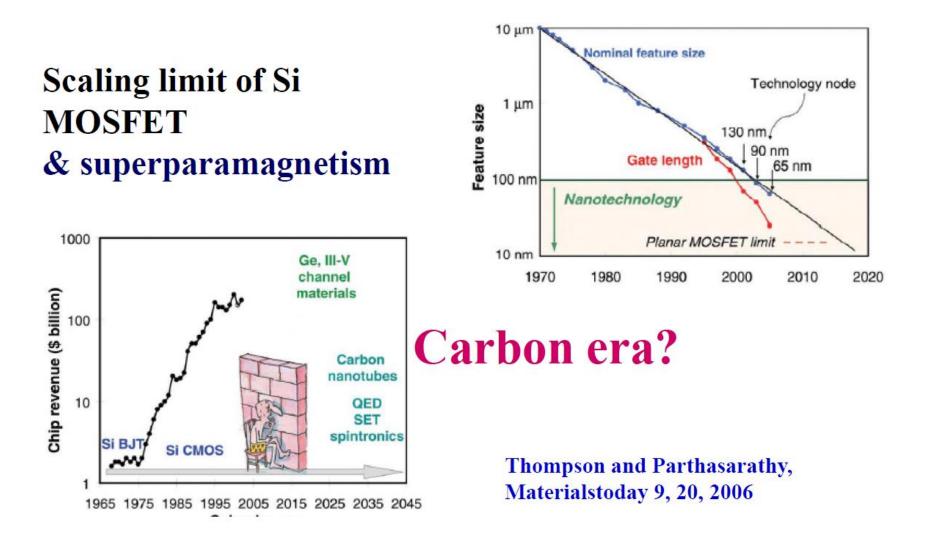
H.-H. Wang et al., Adv. Mater. 18, 491 (2006); T.-T. Liu et al., PLoS ONE 4, e5470 (2009).

Dr. Juen-Kai Wang, CCMS, NTU

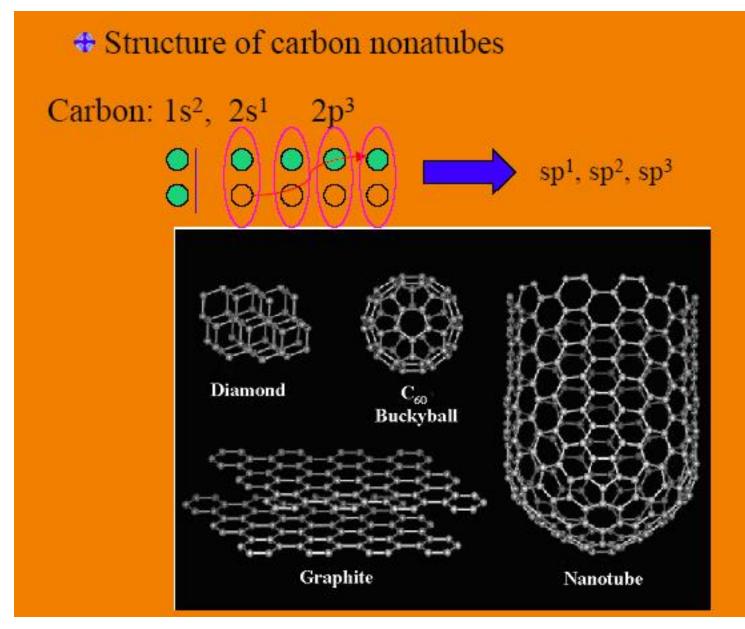
# **The Advent of Carbon Era ?**

The Physics of Graphene: - Possibility of relativistic electronics and spintronics

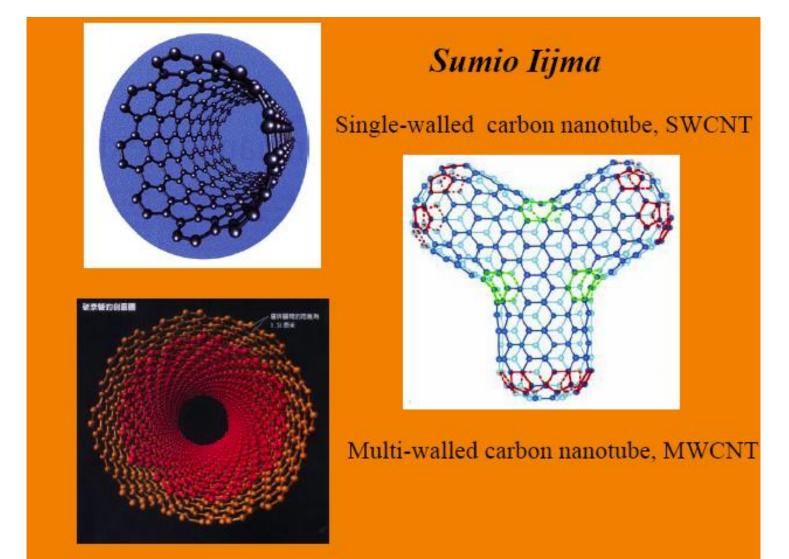
### **Background for search new platform**



### **Carbon Nanotube**



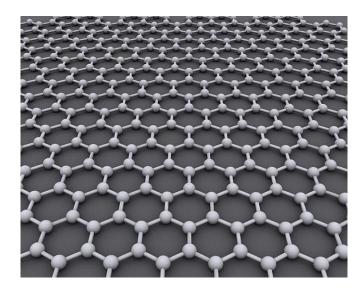
### **Carbon Nanotube**



### **Carbon Nanotube based Transistors / Electronics**

# Unexpected realization of graphene sheet





mechanically exfoliated graphene sheets

AFM image of single-layer graphene on SiO<sub>2</sub> K.S. Novoselove et al., Science 306, 666 (2004)

# Twisted (bilayer) Graphene

θ = 1.1°
Superconductivity
Magnetism

### **Twistronics** ?

# Papers to read

- "Observation of a Magnetic Antiphase Domain Structure with Long-Range Order in a Synthetic Gd-Y Superlattice", C. F. Majkrzak, J. W. Cable, J. Kwo, M. Hong, D. B. McWhan, Y. Yafet, J. V. Waszczak, and C. Vettier, Phys. Rev. Lett. 56, 2700, (1986).
- M. N. Baibich, J. M. Broto, A. Fert, F. Nguyen Van Dau, F. Petroff, *Phys. Rev. Lett.*, 61, 2472 (1988).
- "High k gate dielectrics Gd<sub>2</sub>O<sub>3</sub> and Y<sub>2</sub>O<sub>3</sub> for Si", J. Kwo\*, M. Hong, A.R. Kortan, K. T. Queeney, Y. J. Chabal, J. P. Mannaerts, T. Boone, J. J. Krajewski, A. M. Sergent, and J. M. Rosamilia, Appl. Phys. Lett, **77**, 130, (2000).
- "Epitaxial Cubic Gd<sub>2</sub>O<sub>3</sub> as a Dielectric for GaAs Passivation", M. Hong, J. Kwo, A. R. Kortan, J. P. Mannaerts, and A. M. Sergent, Science, **283**, 1897, (1999).
- "Observation of the Spin Hall Effect in Semiconductors", Y. K. Kato, R. C. Myers, A. C. Gossard, D. D. Awschalom\*, Science **306**, 1910 (2004).
- "Tunnel field-effect transistors as energy-efficient electronic switches", A. M. Ionescu, and H. Riel, Nature, **479**, 329 (2011).